

Electronic Supplementary Information (ESI)

Phase matching achieved by isomorphous substitution in IR nonlinear optical material $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ with an undiscovered $[\text{SnO}_4\text{S}]$ functional motif

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Table of Contents

1 Experimental Section

1.1 Materials and Instruments

1.2 Synthesis

1.3 Single-Crystal Structure determination

1.4 Second-Harmonic Generation (SHG) Measurements

1.5 Laser Induced Damage Threshold (LIDT) Measurements

2 Computational Details

3 Figures and Tables

Figure S1. The coordination environment and bond lengths (Å) of crystallographic independent Ba atoms in $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ and $\text{Ba}_2\text{TiOSi}_2\text{O}_7$.

Electronic Supplementary Information (ESI)

Figure S2. Experimental (black) and simulated (red) powder XRD patterns of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Figure S3. The characterizations of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$: (a) SEM image and corresponding elemental mapping analysis and (b) EDX results.

Figure S4. TG diagram (inset: DSC cyclic curves) of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Figure S5. The PXRD of experimental $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ calcining in 1173 K (blue), simulated $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ (black), and BaSiO_3 (PDF#:70-2112) (red arrow) .

Figure S6. Timeline of mixed-anion NLO-active motifs reported in NCS oxychalcogenides.

Figure S7. The first Brillouin zone with high symmetry points for $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Table S1. Crystallographic data and refinement details for $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Table S2. Atomic coordinates and equivalent isotropic displacement parameters of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Table S3. Selected bond lengths (\AA) and angle ($^\circ$) of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Table S4. Properties comparison of the reported NLO oxychalcogenides.

Table S5. The static SHG coefficients d_{ij} (pm/V) for $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ and $\text{Ba}_2\text{TiOSi}_2\text{O}_7$.

4 References

Electronic Supplementary Information (ESI)

1 Experimental Section

1.1 Materials and Instruments

All reagents used in the present experiments were purchased from commercial sources and directly used without further purification. All weighing processes were completed in an anhydrous and oxygen-free glove box. The semi-quantitative energy dispersive X-ray (EDX, Oxford INCA) spectra were measured with a field emission scanning electron microscope (FESEM, JSM6700F). Powder X-ray diffraction (PXRD) analysis was carried out in a Rigaku Mini-Flex II powder diffractometer (Cu- K_{α} , $\lambda = 1.5418 \text{ \AA}$). UV-vis-NIR absorption measurement was performed in the region of 200–2500 nm at room temperature using an UV-vis-NIR spectrometer (Perkin-Elmer Lambda 950). The reflectance spectrum of the BaSO_4 powder was collected as the baseline and the diffuse reflectance data were converted to absorbance internally by the instrument by use of the Kubelka-Munk function.¹ The IR transmittance was measured on the PerkinElmer Spectrum One FT-IR Spectrometer in the range of 400–4000 cm^{-1} . The thermal stability analyses were measured on a NETZSCH STA 449C simultaneous analyser. The birefringence (Δn) was characterized by using the polarizing microscope (ZEISS Axio Scope, A1) equipped with Berek compensator. The wavelength of the light source was 546 nm. The formula for calculating the Δn is $R = |N_e - N_o| \times T = \Delta n \times T$. Here, R represents the optical path difference and T denotes the thickness of the crystal.

Electronic Supplementary Information (ESI)

1.2 Synthesis

In this work, BaO (4 N), BaS (4 N), SnO₂ (4 N), SiO₂ (3 N), and KBr (3 N) were used as raw materials without further purification. A mixture of BaO (1 mmol), BaS (1 mmol), SnO₂ (1 mmol), SiO₂ (2 mmol), and KBr (2 mmol) was sealed into an evacuated silica tube and subjected to the following heat treatment: quickly heated to 923K in 10hours, held at this temperature for 10 hours, next, quickly heated to 1123K in 10 hours, held at this temperature for 72 hours, then and cooled to ambient conditions at 6 K/h. Finally, the colorless single crystals of Ba₂SnSi₂O₇S with a high yield of 90% (based on Sn) were obtained in air after washed with deionized water and dried with ethanol.

1.3 Single-Crystal Structure determination

Taking some high-quality crystals of Ba₂SnSSi₂O₇with suitable sizes were selected for single-crystal X-ray diffraction (XRD) analysis. The single-crystal diffraction data collections were collected on a Saturn 724 install with graphite-monochromated Mo- K_{α} radiation ($\lambda = 0.71073 \text{ \AA}$) at room temperature. The absorption correction was performed by the multi-scan method.² Using direct methods and maken further refinement by full-matrix least-square fitting on F^2 based on *SHELX-2014* software, the precise struture was determined sussessfully.³ Crystallographic data and refinement details are given in the Table S1. The atomic coordinates and equivalent isotropic of crystallographic information displacement parameters are given in the Table S2. Bond distances (\AA) and bond angles ($^{\circ}$) of Ba₂SnSSi₂O₇ are listed in Table S3. CIFs of Ba₂SnSSi₂O₇ have been submitted with CCDC numbers 2155594.

1.4 Second-Harmonic Generation (SHG) Measurements

According to Kurtz-Perry method, the powder SHG property measurement was performed in 2050 nm and 1064 nm Q-switch laser radiation (laser energy is 10mJ).

Electronic Supplementary Information (ESI)

AgGaS₂ (high quality single crystals as reference material were provided by Anhui Institute of Optics and Fine Mechanics Chinese Academy of Sciences) and KDP were taken as contrast material in the same condition, respectively.⁴ The different granule size scopes (30–46, 46–74, 74–106, 106–150, 150–210 μm) of Ba₂SnSSi₂O₇, AgGaS₂ and KDP were ground and screen out. The SHG intensity of the frequency-doubled output gave out the prepared materials were observed via a photomultiplier tube and saved on the oscilloscope.

1.5 Laser Induced Damage Threshold (LIDT) Measurements

The LIDT of Ba₂SnSSi₂O₇ at the maximal scope of 150–210 μm was carried out single pulse measurement method⁵ and similar scope of AgGaS₂ and KDP single crystals used to the references. The whole measuring materials were foist into selfsame plastic holders (thickness: 1 mm and diameter: 8 mm), respectively. Using an optical microscope monitor the exterior change of sample under the 1064 nm laser radiation with pulse width τ_p of 10 ns. Nova II sensor with a PE50-DIF-C energy sensor and a Vernier caliper was used for measuring the power of laser beam and the damage spot radius.

2 Computational Details

The DFT calculations have been performed using the *Vienna ab initio simulation package* (VASP)^{6–8} with the Perdew-Burke-Ernzerhof (PBE)⁹ exchange correlation functional. The projected augmented wave (PAW)¹⁰ potentials with the valence states 5s, 5p and 6s for Ba, 5s and 5p for Sn, 3s and 3p for Si, 3s and 3p for S, and 2s and 2p for O, respectively, have been used. A Γ -centered 7 \times 7 \times 9 Monkhorst-Pack grid for the Brillouin zone sampling¹¹ and a cutoff energy of 750 eV for the plane wave expansion were found to get convergent lattice parameters. The linear and nonlinear optical

Electronic Supplementary Information (ESI)

calculation was performed in the condition of a Monkhorst-Pack k -point mesh of $7 \times 9 \times 9$.

The imaginary part of the dielectric function due to direct inter-band transitions is given by the expression:

$$\varepsilon_2(\hbar\omega) = \frac{2e^2\pi}{\Omega\varepsilon_0} \sum_{k,v,c} \left| \langle \psi_k^c | u \cdot r | \psi_k^v \rangle \right|^2 \delta(E_k^c - E_k^v - E) \dots\dots\dots (1)$$

where Ω , ω , u , v and c are the unit-cell volume, photon frequencies, the vector defining the polarization of the incident electric field, valence and conduction bands, respectively. The real part of the dielectric function is obtained from ε_2 by a Kramers-Kronig transformation:

$$\varepsilon_1(\omega) = 1 + \left(\frac{2}{\pi}\right) \int_0^{+\infty} d\omega' \frac{\omega'^2 \varepsilon_2(\omega')}{\omega'^2 - \omega^2} \dots\dots\dots (2)$$

The refractive index $n(\omega)$ can be obtained based on ε_1 and ε_2 .

In calculation of the static $\chi^{(2)}$ coefficients, the so-called length-gauge formalism¹² derived by Aversa and Sipe¹³ and modified by Rashkeev et al¹⁴ is adopted, which has proven to be successful in calculating the second order susceptibility for semiconductors and insulators. In the static case, the imaginary part of the static second-order optical susceptibility can be expressed as:

$$\begin{aligned} \chi^{abc} &= \frac{e^3}{\hbar^2\Omega} \sum_{nml,k} \frac{r_{nm}^a (r_{ml}^b r_{ln}^c + r_{ml}^c r_{ln}^b)}{2\omega_{nm}\omega_{ml}\omega_{ln}} [\omega_n f_{ml} + \omega_m f_{ln} + \omega_l f_{nm}] \\ &+ \frac{ie^3}{4\hbar^2\Omega} \sum_{nm,k} \frac{f_{nm}}{\omega_{mn}^2} [r_{nm}^a (r_{mn;c}^b + r_{mn;b}^c) + r_{nm}^b (r_{mn;c}^a + r_{mn;a}^c) + r_{nm}^c (r_{mn;b}^a + r_{mn;a}^b)] \\ &\dots\dots\dots(3) \end{aligned}$$

where r is the position operator, $\hbar\omega_{nm} = \hbar\omega_n - \hbar\omega_m$ is the energy difference for the bands m and n , $f_{mn} = f_m - f_n$ is the difference of the Fermi distribution functions,

Electronic Supplementary Information (ESI)

subscripts a , b , and c are Cartesian indices, and $r_{mn;a}^b$ is the so-called generalized derivative of the coordinate operator in k space,

$$r_{nm;a}^b = \frac{r_{nm}^a \Delta_{mn}^b + r_{nm}^b \Delta_{mn}^a}{\omega_{nm}} + \frac{i}{\omega_{nm}} \times \sum_l (\omega_{lm} r_{nl}^a r_{lm}^b - \omega_{nl} r_{nl}^b r_{lm}^a) \dots\dots\dots (4)$$

where $\Delta_{nm}^a = (p_{nn}^a - p_{mm}^a) / m$ is the difference between the electronic velocities at the bands n and m .

As the nonlinear optical coefficients is sensitive to the momentum matrix, much finer k-point grid and large amount of empty bands are required to obtain a convergent $\chi^{(2)}$ coefficient. The $\chi^{(2)}$ coefficients here were calculated from PBE wave functions and a scissor operator has been added to correct the conduction band energy (corrected to the experimental gap), which has proven to be reliable in predicting the second order susceptibility for semiconductors and insulators.

Electronic Supplementary Information (ESI)

3 Figures and Tables

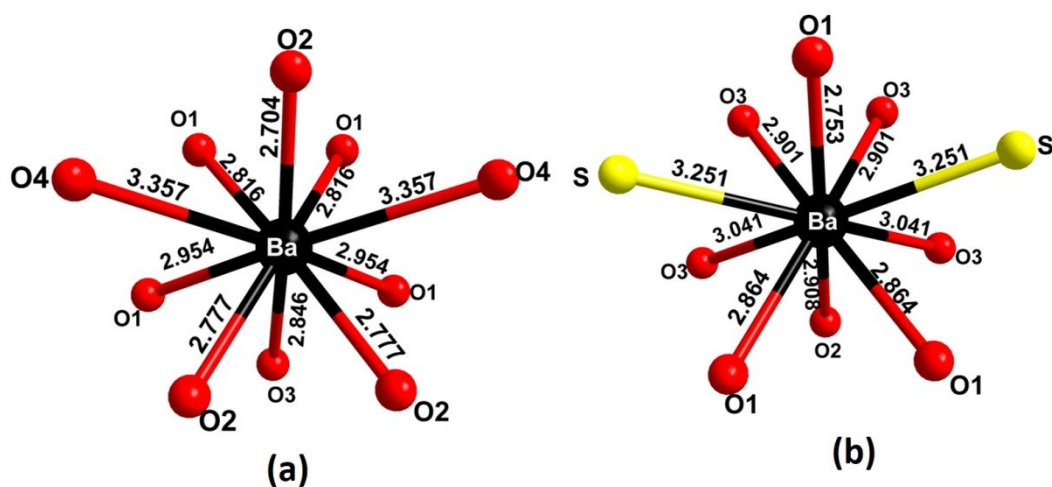


Figure S1. The coordination environment and bond lengths (Å) of crystallographic independent Ba atoms in (a) $\text{Ba}_2\text{TiOSi}_2\text{O}_7$ and (b) $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

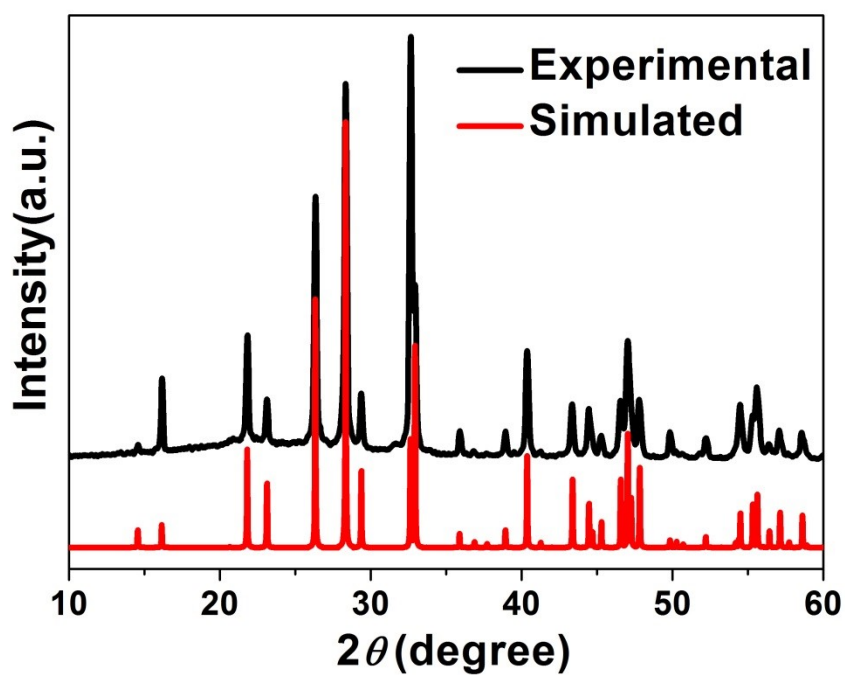


Figure S2. Experimental (black) and simulated (red) powder XRD patterns of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Electronic Supplementary Information (ESI)

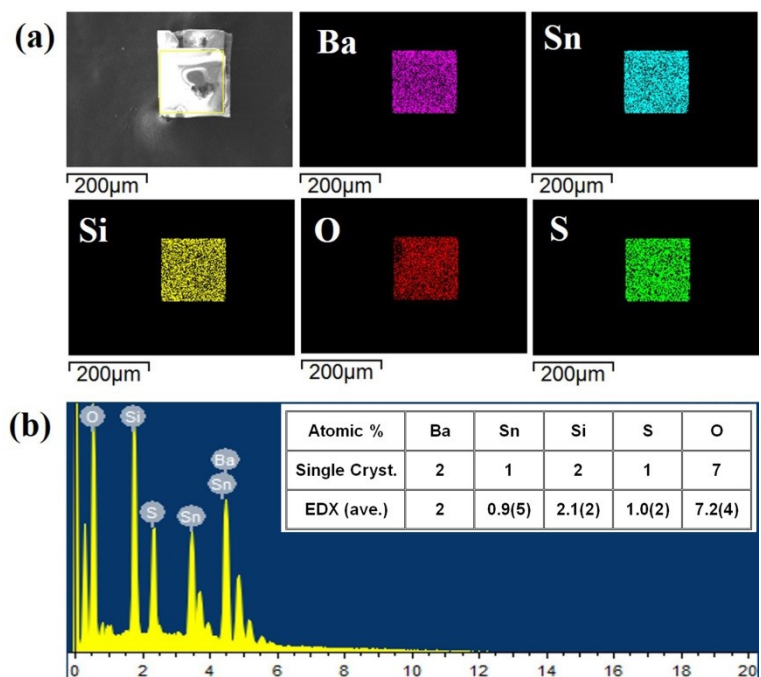


Figure S3. The characterizations of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$: (a) SEM image and corresponding elemental mapping analysis and (b) EDX results.

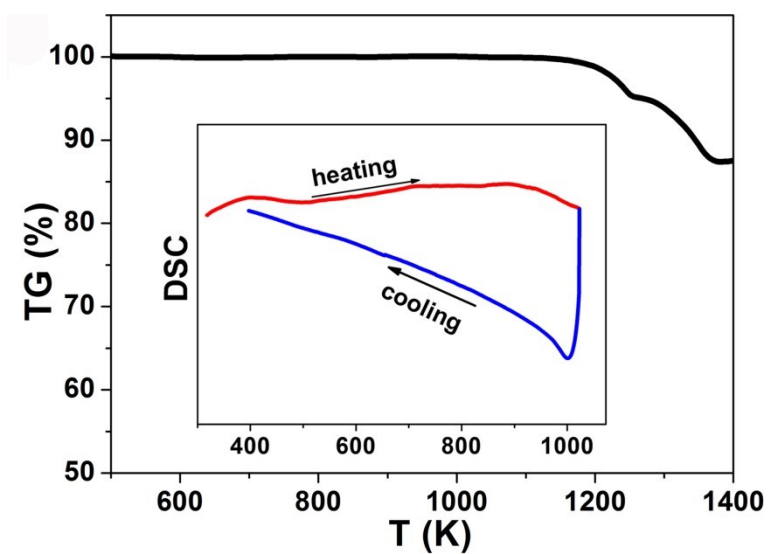


Figure S4. TG diagram (inset: DSC cyclic curves) of $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Electronic Supplementary Information (ESI)

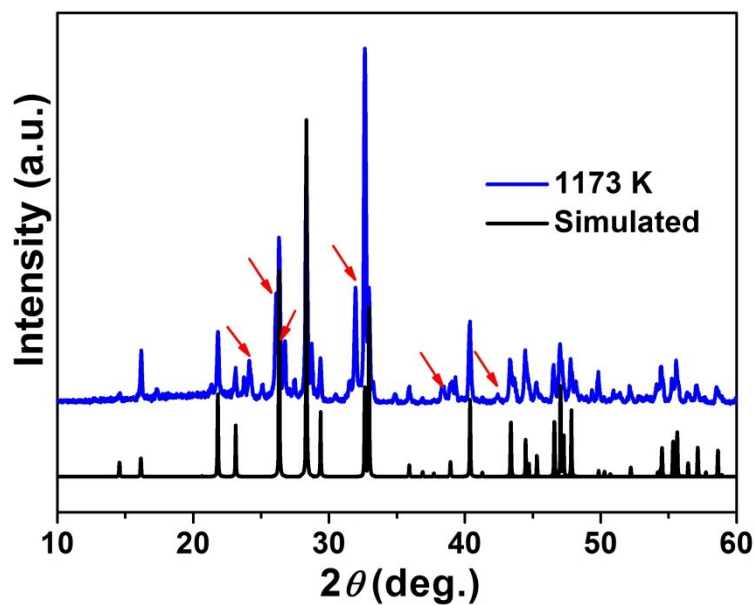


Figure S5. The PXRD of experimental $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ calcining in 1173 K (blue), simulated $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ (black), and BaSiO_3 (PDF#:70-2112) (red arrow) .

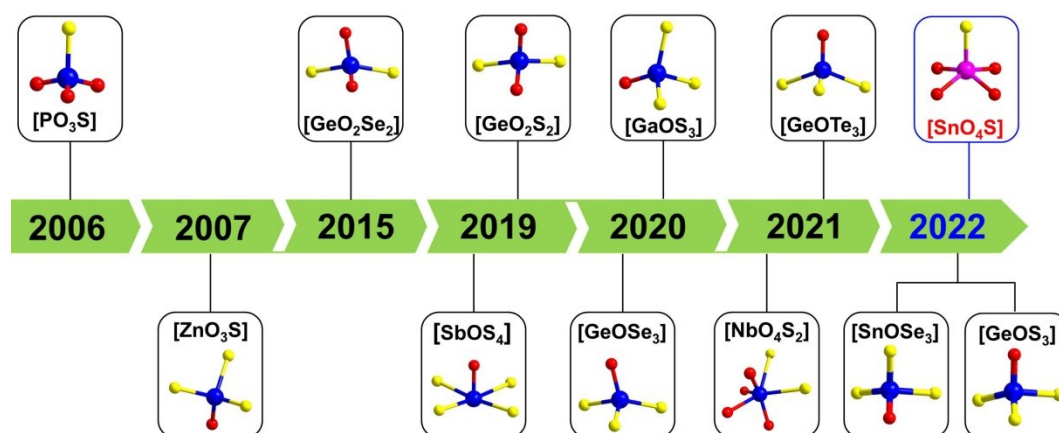


Figure S6. Timeline of mixed-anion NLO-active motifs reported in NCS oxychalcogenides.

Electronic Supplementary Information (ESI)

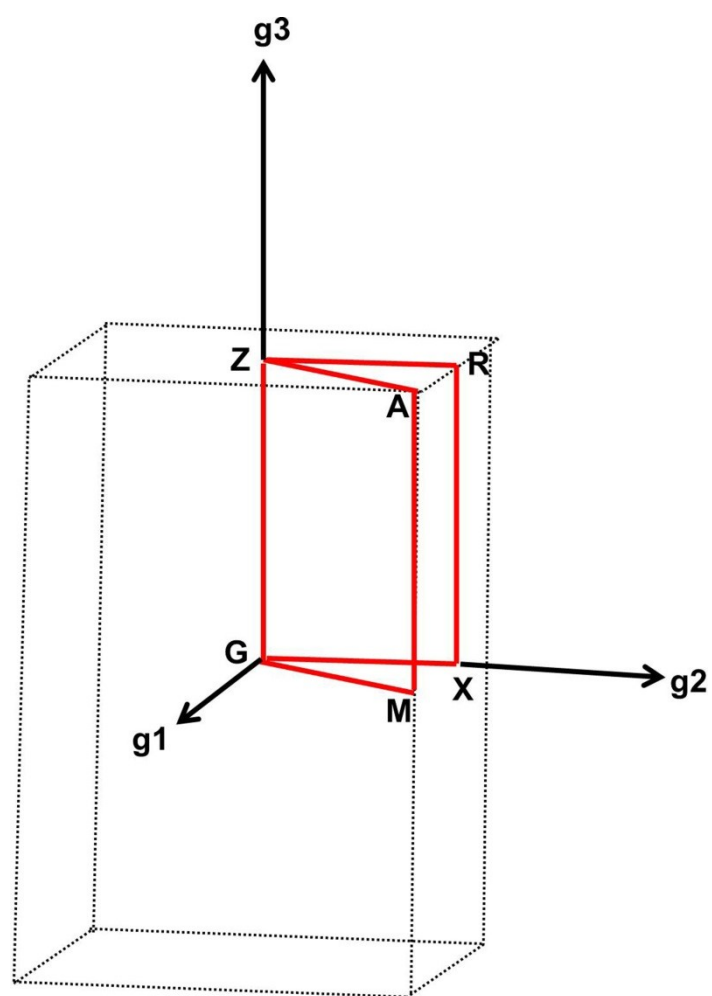


Figure S7. The first Brillouin zone with high symmetry points for $\text{Ba}_2\text{SnSSi}_2\text{O}_7$.

Electronic Supplementary Information (ESI)

Table S1. Crystallographic data and refinement details for Ba₂SnSSi₂O₇.

Empirical formula	Ba ₂ SnSSi ₂ O ₇
Formula weight	593.61
Temperature(K)	293(2)
Crystal size (mm)	0.25 × 0.2 × 0.2
Crystal system	Tetragonal
Space group	<i>P4bm</i> (No.100)
<i>a</i> (Å)	8.5915(3)
<i>b</i> (Å)	8.5915(3)
<i>c</i> (Å)	5.4835(4)
<i>V</i> (Å ³)	404.76(4)
<i>Z</i>	2
<i>D_c</i> (g·cm ⁻³)	4.871
<i>μ</i> (mm ⁻¹)	13.237
GOOF on <i>F</i> ²	1.005
<i>R</i> ₁ , <i>wR</i> ₂ (<i>I</i> > 2σ(<i>I</i>)) ^a	0.0142, 0.0360
<i>R</i> ₁ , <i>wR</i> ₂ (all data)	0.0142, 0.0360
Largest diff. peak and hole (e·Å ⁻³)	0.542, -0.518
Flack parameter	0.06(2)

Electronic Supplementary Information (ESI)

Table S2. Atomic coordinates and equivalent isotropic displacement parameters of Ba₂SnSSi₂O₇.

Atom	<i>Wyckff</i>	<i>x</i>	<i>y</i>	<i>z</i>	$U_{\text{eq}}(\text{\AA})^{\text{a}}$
Ba	<i>4c</i>	0.32840(3)	0.82840(3)	0.12052(11)	0.00531(18)
Sn	<i>2a</i>	0	0	0.57697(12)	0.0063(2)
Si	<i>4c</i>	0.87354(15)	0.37354(15)	0.6044(5)	0.0059(4)
S	<i>2a</i>	0	0	0	0.0071(5)
O1	<i>4c</i>	0.8742(5)	0.3742(5)	0.8956(11)	0.0059(10)
O2	<i>2b</i>	0.5	0	0.4901(16)	0.0186(19)
O3	<i>8d</i>	0.7880(5)	0.9223(6)	0.4693(9)	0.0223(11)

U_{eq} is defined as one third of the trace of the orthogonalized U_{ij} tensor.

Electronic Supplementary Information (ESI)

Table S3. Selected bond lengths (Å) and angle (°) of Ba₂SnSSi₂O₇.

Sn–S3×4	2.028(5)	∠ O3–Sn–O3×2	146.1(3)
Sn–S	2.320(3)	∠ O3–Sn–O3×4	85.13(8)
Si–O1	1.597(6)	∠ O3–Sn–S×4	106.94(13)
Si–O3×2	1.628(8)	∠ O1–Si–O3×2	117.2(2)
Si–O1	1.659(4)	∠ O3–Si–O3	103.4(4)
Ba–O1×2	2.865(4)	∠ O3–Si–O2×2	102.6(3)
Ba–O1	2.753(6)	∠ O3–Si–O3	111.9(4)
Ba–O3×2	2.901(5)		
Ba–O3×2	3.041(5)		
Ba–S×2	3.2513(6)		

Electronic Supplementary Information (ESI)

Table S4. Properties comparison of the reported NLO oxychalcogenides.

Compounds	Space group	E_g (eV)	d_{eff}	PM/NPM	Ref.
α -Na ₃ PO ₃ S	<i>R3c</i> (No. 161)	N/A	$200 \times \text{SiO}_2$	NPM	15
Sr ₄ Pb _{1.5} Sb ₅ O ₅ Se ₈	<i>Cm</i> (No. 8)	0.92	$0.25 \times \text{AgGaS}_2$	N/A	16
Sr ₆ Cd ₂ Sb ₆ O ₇ S ₁₀	<i>Cm</i> (No. 8)	1.89	$4 \times \text{AgGaS}_2$	PM	17
Ba ₃ Ge ₂ O ₄ Te ₃	<i>R3m</i> (No. 160)	2.08	$0.6 \times \text{AgGaSe}_2$	PM	18
Sm ₃ NbS ₃ O ₄	<i>Pna2</i> ₁ (No. 33)	2.68	$0.3 \times \text{AgGaS}_2$	PM	19
Gd ₃ NbS ₃ O ₄	<i>Pna2</i> ₁ (No. 33)	2.74	$0.4 \times \text{AgGaS}_2$	PM	19
Sr ₃ Ge ₂ O ₄ Se ₃	<i>R3m</i> (No. 160)	2.96	$0.8 \times \text{AgGaS}_2$	PM	20
SrGeOSe ₂	<i>P2</i> ₁ <i>2</i> ₁ <i>2</i> ₁ (No. 19)	3.16	$1.3 \times \text{AgGaS}_2$	PM	21
BaGeOSe ₂	<i>P2</i> ₁ <i>2</i> ₁ <i>2</i> ₁ (No. 19)	3.2	$1.1 \times \text{AgGaS}_2$	PM	22
Sr ₃ [SnOSe ₃][CO ₃]	<i>Pna2</i> ₁ (No. 33)	3.16	$1.0 \times \text{AgGaS}_2$	PM	23
Sr ₂ MnGe ₂ OS ₆	<i>P</i> ⁴ <i>2</i> ₁ <i>m</i> (No. 113)	3.51	$0.3 \times \text{AgGaS}_2$	PM	24
Sr ₂ CdGe ₂ OS ₆	<i>P</i> ⁴ <i>2</i> ₁ <i>m</i> (No. 113)	3.62	$0.8 \times \text{AgGaS}_2$	PM	24
Sr ₂ ZnGe ₂ OS ₆	<i>P</i> ⁴ <i>2</i> ₁ <i>m</i> (No. 113)	3.73	$0.6 \times \text{AgGaS}_2$	PM	24
CaZnOS	<i>P6</i> ₃ <i>mc</i> (No. 186)	3.71	$100 \times \text{SiO}_2$	NPM	25
SrZn ₂ OS ₂	<i>Pmn2</i> ₁ (No. 31)	3.86	$2 \times \text{KDP}$	PM	26
Sr ₅ Ga ₈ O ₃ S ₁₄	<i>P2</i> ₁ <i>2</i> ₁ <i>2</i> (No. 18)	3.9	$0.8 \times \text{AgGaS}_2$	NPM	27
SrGeOS ₂	<i>P2</i> ₁ <i>2</i> ₁ <i>2</i> ₁ (No. 19)	3.9	$0.4 \times \text{AgGaS}_2$	NPM	28
Ba₂SnSSi₂O₇	<i>P4bm</i> (No. 100)	4.05	$0.6 \times \text{AgGaS}_2$	PM	This Work
BaGeOS ₂	<i>P2</i> ₁ <i>2</i> ₁ <i>2</i> ₁ (No. 19)	4.1	$0.5 \times \text{AgGaS}_2$	NPM	28
La ₃ Ga ₃ Ge ₂ S ₃ O ₁₀	<i>P</i> ⁶ <i>2c</i> (No. 190)	4.7	$2 \times \text{KDP}$	PM	29

Electronic Supplementary Information (ESI)

Table S5. The static SHG coefficients d_{ij} (pm/V) for $\text{Ba}_2\text{SnSSi}_2\text{O}_7$ and $\text{Ba}_2\text{TiOSi}_2\text{O}_7$.

Compounds	$\text{Ba}_2\text{SnSSi}_2\text{O}_7$	$\text{Ba}_2\text{TiOSi}_2\text{O}_7$
	$d_{31} = 1.030$	$d_{31} = 0.721$
d_{ij} (pm/V) at 2050 nm	$d_{32} = 1.034$	$d_{32} = 0.724$
	$d_{33} = 2.95$	$d_{33} = 2.06$

Electronic Supplementary Information (ESI)

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